

Notice of References Cited	Application/Control No. 10/659,624	Applicant(s)/Patent Under Reexamination GOUO, AKIO	
	Examiner Paul D. Kim	Art Unit 3729	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,460,245	10-2002	DiStefano, Thomas H.	29/840
	B	US-5,258,330	11-1993	Khandros et al.	29/593
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 03121413 A	05-1991	Japan	OBARA et al.	G02F 01/13
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Monolithic sampling head IC"; Miura, A.; Yakihara, T.; Uchida, S.; Oka, S.; Kobayashi, S.; Kamada, H.; Dobashi, M.; Microwave Theory and Techniques, IEEE Transactions on Volume 38; Dec 1990 Page(s):1980 - 1985.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.